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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT	MMB DOCKET NO. 1890-0038	APPLICATION NO.: 10/757,360			
JUL 2 3 2004 CG	APPLICANT(S): Kriz et al.				
	FILING DATE: January 13, 2004	GROUP ART UNIT: 2812			

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CAC	AL	DE 3940674 A1	June 28, 1990	Germany			Yes No
Al	AM	DE 3304642 A1	August 16, 1984	Germany			Yes No
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CAL	AO	CA 01 201 218	February 25, 1986	Canada			Yes No
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